Searcn Notes			
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/801,894	JIAO ET AL.	
Examiner	Art Unit	
Khiem D. Nauven	2823	

SEARCHED			
Class	Subclass	Date	Examiner
438	118	11/8/2006	K.N.
438	119	11/8/2006	K.N.
257	783	11/8/2006	K.N.
257	E23.018	11/8/2006	K.N.
257	E23.166	11/8/2006	K.N.
257	E21.514	11/8/2006	K.N.
. 257	E23.075	11/8/2006	K.N.

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB), see attached search history.	11/8/2006	K.N.		
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